

L Number	Hits	Search Text	DB	Time stamp
-	1974	438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.	USPAT	2004/04/09 13:53
-	1794	324/765.ccls.	USPAT	2004/04/08 18:36
-	1829	(438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) not 324/765.ccls.	USPAT	2004/04/06 20:44
-	788	((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) not 324/765.ccls.) and voltage	USPAT	2004/03/25 15:28
-	2000	438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.	USPAT	2004/03/29 14:30
-	27	(438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) and (probe adj tip)	USPAT	2004/03/25 14:52
-	15	(semiconductor and (electric adj field) and voltage and detect\$3) and (stimulate with circuit\$2)	USPAT	2004/03/25 15:32
-	577	DUT with voltage	USPAT	2004/03/29 14:30
-	2000	438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.	USPAT	2004/03/29 14:30
-	459	(DUT with voltage) not ((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.)	USPAT	2004/03/29 14:31
-	1831	324/765.ccls.	USPAT	2004/04/06 20:16
-	262	324/765.ccls. and DUT	USPAT	2004/04/06 20:16
-	3	((("6417680") or ("6412086") or ("5493236"))).PN.	USPAT	2004/04/06 20:44
-	737	scanning adj probe adj microscope	USPAT	2004/04/08 18:37
-	1831	324/765.ccls.	USPAT	2004/04/08 18:37
-	3703	(438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.	USPAT	2004/04/08 18:37
-	14	((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.) and (scanning adj probe adj microscope)	USPAT	2004/04/08 18:44
-	42	((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.) and (atomic adj force adj microscope)	USPAT	2004/04/08 18:45
-	29	((((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.) and (atomic adj force adj microscope)) not (((438/5.ccls. or 438/10.ccls. or 438/11.ccls. or 438/12.ccls. or 438/14.ccls. or 438/17.ccls. or 438/18.ccls.) or 324/765.ccls.) and (scanning adj probe adj microscope)))	USPAT	2004/04/08 18:45
-	82	AFM with nanometer	USPAT	2004/04/09 14:07
-	14	AFM and ((probe adj tip) with nanometer)	USPAT	2004/04/09 14:14
-	1	"6448096"	USPAT	2004/04/09 14:58
-	0	"6448096" and nanometer	USPAT	2004/04/09 14:15
-	0	"6448096" and nanometers	USPAT	2004/04/09 14:15
-	0	"6448096" and nano\$6	USPAT	2004/04/09 14:15
-	1	"6448096" and flip	USPAT	2004/04/09 14:59
-	2969	(scanning adj probe adj microscope) or (atomic adj force adj microscope) or (capacitance adj probe adj microscope)	USPAT	2004/10/03 22:56
-	1674	((scanning adj probe adj microscope) or (atomic adj force adj microscope) or (capacitance adj probe adj microscope)) and (voltage)	USPAT	2004/10/03 22:56
-	104	((scanning adj probe adj microscope) or (atomic adj force adj microscope) or (capacitance adj probe adj microscope)) with (voltage)	USPAT	2004/10/03 22:56
-	104	((scanning adj probe adj microscope) or (atomic adj force adj microscope) or (capacitance adj probe adj microscope)) with voltage	USPAT	2004/10/04 16:37
-	8	white.in. and karlsen.xp.	USPAT	2004/10/04 16:40
-	1373	73/104.ccls. or 73/105.ccls.	USPAT	2004/10/04 16:40
-	1239	250/306.ccls.	USPAT	2004/10/04 16:40
-	229	324/750.ccls.	USPAT	2004/10/04 16:40
-	2006	324/765.ccls.	USPAT	2004/10/04 16:41
-	4587	(73/104.ccls. or 73/105.ccls.) or 250/306.ccls. or 324/750.ccls. or 324/765.ccls.	USPAT	2004/10/04 16:41
-	2633	((73/104.ccls. or 73/105.ccls.) or 250/306.ccls. or 324/750.ccls. or 324/765.ccls.) and voltage	USPAT	2004/10/04 16:41

-	109	((73/104.ccls. or 73/105.ccls.) or 250/306.ccls. or 324/750.ccls. or 324/765.ccls.) and (voltage and die and electric)	USPAT	2004/10/04 16:41
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